Notice of References Cited	Application/Control No.  Applicant(s)/Patent Under Reexamination TERADA ET AL.		nt Under	
Notice of Nerelences Offed	Examiner	Art Unit	Page 1 of 1	
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## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2002/0034686	03-2002	Yamakawa et al.	429/217
*	В	US-2005/0064096	03-2005	Kurihara et al.	427/215
	U	US-			
	D	US-			
	Е	US-			
	F	US-			
	G	US-			
	Ι	US-			
	-	US-			
	J	US-			
	K	US-			
	┙	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Ν	JP 2000040504 A	02-2000	Japan	YAMAGUCHI et al.	
	0	JP 04233209 A	08-1992	Japan	KUNISHI et al.	
	Ρ					
	Ø					
	R					
	Ø					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)		
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	W			
	х			

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